

Notice of References Cited	Application/Control No. 10/519,242		Applicant(s)/Patent Under Reexamination AKIYAMA ET AL.	
	Examiner Ives Wu		Art Unit 1724	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2004/0023156 A1	02-2004	McGinness et al.	430/271.1
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